

<b>Notice of References Cited</b>	Application/Control No. 10/657,335		Applicant(s)/Patent Under Reexamination HABERMAN ET AL.	
	Examiner KUNAL LANGHNOJA		Art Unit 4115	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,761,601	06-1998	Nemirofsky et al.	725/34
*	B	US-2003/0221191	11-2003	Khusheim, Raed	725/35
*	C	US-RE38,376	12-2003	Matthews, III, Joseph H.	725/34
*	D	US-2003/0177490	09-2003	Hoshino et al.	725/34
*	E	US-2003/0149976	08-2003	Shah-Nazaroff et al.	725/34
*	F	US-2003/0145323	07-2003	Hendricks et al.	725/34
*	G	US-2004/0237102	11-2004	Konig et al.	725/036
*	H	US-2003/0067554	04-2003	Klarfeld et al.	348/461
*	I	US-2003/0188311	10-2003	Yuen et al.	725/42
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.